# Beamtest of ABCD2T and CAFE/ABC modules at KEK

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# Dec99 beamtest at KEK (T450)

# • Execution: Dec 10-21, 1999

 $\pi \mathbf{2}$  beamline in the 12 GeV PS at KEK, 4 GeV/c  $\pi^{\text{-}}$ 

**Participants:** 

Domestic = Y. Unno, Y. Ikegami, T. Kohriki, +6~9 students Abroad = G. Moorhead, K. Runge, J. Ludwig, Z. Dolezal Photo's out of the beamtest

# • DUT's: 4 full modules + 1 irradiated det-module

Module 0: KEK-ABCD#1 , 12 chips, 285 um, trim 2 fC=200 mV Module 1: FR-ABCD, 12 chips, 285 um, trim 2 fC=200 mV Module 2: KEK-ABCD#2, 12 chips, 325 um, no trim Module 3: FR-irrad det-ABCD, 2 chips, 285 um, trim 2fC=200 mV Module 4: KEK-CAFE/ABC, 12 chips, 285 um Module 5: CG3, anchor

## • Run conditions:

Edge detection=ON, Mode=Any hits 2cm x 2cm triggered region with 3 planes of scintillator Two temperatures: +10, and -10 °C +10 °C = Mod0, Mod1, Anchor -10 °C = All











# **Modules setup**

# • Beam defining: Three telescope planes + Anchor

Two DUT's between telescopes or anchor		
Separation: 30 mm each		
Sequence:		
Telescope1		
Mod0	KEK-ABCD#1	
Mod1	Freiburg-ABCD	
- (6 mm Al plate): accidentally left-over		
Telescope2		
Mod2	KEK-ABCD#2	
Mod3	Freiburg-irradiated detector	
Telescope3		
Mod4	KEK-CAFE/ABC	
Anchor (CG3)		
No shielding between the DUTs		

# • Setup drawing

Setup of -10 °C

# Calibration

## • In-situ calibration runs:

Bias 100V (irrad 350V) Scan points were fed into the thresholds of beamtest Edge detection = OFF Mode = X1X

Later, a response curve and charge values are corrected Scan points with larger markers were those used for the fit

# • Det4(Mod4):

Threshold in (ABCD) mV 640 (ABCD)mV~680 (CAFE)mV open square (nominal scale) filled square (KEK internal) Nominal charge scale: IDAR~300 μA = 10 fC KEK internal scale: IDAR~300 μA ~ 7 fC

# Calibration (cont'd)

## • Noise sigma:

Module	Calibration	Noise [e]
Mod0 - KEK-ABCD#1	in-situ	~1460
Mod1 - Freiburg ABCD	in-situ	~1470
Mod2 - KEK-ABCD#2	in-situ	~1515(1680) <sup>a</sup>
Mod4 - KEK CAFE/ABC	in-situ	~1600
	Module@Fuji	~1690
	Hybrid@Fuji	~890

#### • Notes:

- Mod2:

<sup>a</sup>Chip6,7 were noiser than the rest

<sup>a</sup>Chip3 was too large trim step

No particular characteristics in wafer probed data

#### - Mod4:

CAFE/ABC in nominal charge scale, IDAR ~300 uA=10fC

#### - Temperatures:

In-situ: -10 °C environment air cooled

@Fuji: +20 °C environment air cooled



THRESHOLD%Q



THRESHOLD%Q

# det4



THRESHOLD%Q

# **Threshold scans**

#### • In beam

Scan points: typically, 0.8, 1.0,..., 2.2, 2.5, 3.0,..., 8.0 fC Bias voltages of 60, 80, 100, 120, 140, 160, 180, 200 V 5k events per point, several points in 10k or more

low threshold points being re-calibrated after the calibration curve fit

#### • Efficiency

Tracks in 3 telescopse and anchor

Window (+-250  $\mu\text{m})$  from a track defined by two adjacent telescopes

Any time bins

# Position resolution

Residual of the nearest hit to the track defined by two adjacent telescopes



Hit map ( KEK3103 : 120V, 1.2fC )

ModOs1 hitmap (channel)



Efficiency in strip (ModOs1)



#### **Position Resolution(1.2fC, 120V)**



#### **Position Resolution(1.2fC, 120V)**

Diff (Nearest clus - track) (Mod2s1)

Efficiency



# Bias voltage dependence of median charges

# • Charges of 50% efficiency derived from the fits

All 285  $\mu$ m detector modules saturate at about 3.3 fC

- 325  $\mu\text{m}$  detector at about 3.8 fC, see renormalization

Saturation above 120 V

- Required ~50V overdepletion to get full charge

CAFE/ABC nominal charge scale seems correct

# • Mod2(325 um) renormalization to thickness 285 um

Bias voltage  $\propto$  (Depletion thickness)<sup>2</sup> Collected charge  $\propto$  Depletion thickness

Bias voltage (285 $\mu$ ) = (285 $\mu$ /325 $\mu$ )<sup>2</sup> \* Bias voltage(325 $\mu$ ) factor = 0.77 Median charge (285 $\mu$ ) = (285 $\mu$ /325 $\mu$ ) \* Median charge (325 $\mu$ ) factor = 0.88

Saturation at about 3.4 fC at ~130 V





# Noise occupancy

#### • Hit strip counts

Outside of the efficiency window efficiency window: +- 250  $\mu$ m from the expected track Outside = 2 x efficiency window

## • Time bin info, "100", "010", or "001"

ABCD beam timing = mostly 010 and a fraction in 100, i.e.,

CAFE/ABC=100

Higher occupancy in thresholds > 1.2 fC, in time, = accidental coincidence with beam halo?

#### • Noise occupancy

 $1.35 \times 10^{-3}$  @ 3sigma 3.17x10<sup>-5</sup> @ 4sigma 1 fC = 6250 e If 4 sigma = 0.8 ~ 1.0 fC, then sigma = 0.2 ~ 0.25 fC, i.e., sigma = 1250 ~ 1560 e

## • Notes:

Possible systematic uncertainity of at most 0.2 fC in the charge near 1fC threshold





Occupancy.vs.Qth



Occupancy.vs.Qth



Occupancy.vs.Qth



Occupancy.vs.Qth



Occupancy.vs.Qth



Occupancy.vs.Qth

# Summary

## • Dec 99 beamtest at KEK was carried out successfully

with a new PC-based SCTDAQ 4 ABCD2T and 1 CAFE/ABC modules

#### • Position resolution

Consistent with pitch/sqrt(12) ~ 23  $\mu$ m

#### • Reasonable behaviours of median charges

Saturation above 120 V Saturation at 3.3 fC for 285  $\mu$ m thickness

# • ASIC/hybrid/Module performance

ABCD2T:

noise~ 1450 e (module charge inj. calibration)

CAFE/ABC:

Noise ~ 1550 e (module charge inj. cal., -10 °C)